## N－Channel 80 V（D－S）MOSFET

| PRODUCT SUMMARY |  |  |
| :--- | :---: | :---: |
| $\mathrm{V}_{\mathrm{DS}}$ | 80 | V |
| $\mathrm{R}_{\mathrm{DS}(\mathrm{on})} \mathrm{V}_{\mathrm{GS}}=10 \mathrm{~V}$ | 6 | $\mathrm{~m} \Omega$ |
| $\mathrm{R}_{\mathrm{DS} \text {（on）}} \mathrm{V}_{\mathrm{GS}}=4.5 \mathrm{~V}$ | 10 | $\mathrm{~m} \Omega$ |
| $\mathrm{I}_{\mathrm{D}}$ | 120 | A |
| Configuration | Single |  |

## FEATURES

－ThunderFET ${ }^{\circledR}$ power MOSFET
－Maximum $175{ }^{\circ} \mathrm{C}$ junction temperature
RoHS
－ $100 \% \mathrm{R}_{\mathrm{g}}$ and UIS tested
－Material categorization： for definitions of compliance please see


| ABSOLUTE MAXIMUM RATINGS（ $\mathrm{T}_{\mathrm{C}}=25^{\circ} \mathrm{C}$ ，unless otherwise noted） |  |  |  |  |
| :---: | :---: | :---: | :---: | :---: |
| PARAMETER |  | SYMBOL | LIMIT | UNIT |
| Drain－Source Voltage |  | $\mathrm{V}_{\text {DS }}$ | 80 | V |
| Gate－Source Voltage |  | $V_{G S}$ | $\pm 20$ |  |
| Continuous Drain Current（ $\mathrm{T}_{J}=150^{\circ} \mathrm{C}$ ） | $\mathrm{T}_{\mathrm{C}}=25^{\circ} \mathrm{C}$ | ID | 120 | A |
|  | $\mathrm{T}_{\mathrm{C}}=125^{\circ} \mathrm{C}$ |  | 65 |  |
| Pulsed Drain Current（ $\mathrm{t}=100 \mu \mathrm{~s}$ ） |  | $\mathrm{I}_{\mathrm{DM}}$ | 225 |  |
| Avalanche Current | $\mathrm{L}=0.1 \mathrm{mH}$ | $\mathrm{I}_{\text {AS }}$ | 50 |  |
| Single Avalanche Energy ${ }^{\text {a }}$ |  | $\mathrm{E}_{\text {AS }}$ | 125 | mJ |
| Maximum Power Dissipation ${ }^{\text {a }}$ | $\mathrm{T}_{\mathrm{C}}=25^{\circ} \mathrm{C}$ | $\mathrm{P}_{\mathrm{D}}$ | $370{ }^{\text {b }}$ | W |
|  | $\mathrm{T}_{\mathrm{C}}=125^{\circ} \mathrm{C}$ |  | $120{ }^{\text {b }}$ |  |
| Operating Junction and Storage Temperature Range |  | $\mathrm{T}_{\mathrm{J}}, \mathrm{T}_{\text {stg }}$ | -55 to +175 | ${ }^{\circ} \mathrm{C}$ |

THERMAL RESISTANCE RATINGS

| PARAMETER | SYMBOL | LIMIT | UNIT |
| :--- | :---: | :---: | :---: |
| Junction－to－Ambient（PCB Mount）$^{\text {c }}$ | $\mathrm{R}_{\text {thJA }}$ | 40 | ${ }^{\circ} \mathrm{C} / \mathrm{W}$ |
| Junction－to－Case（Drain）$^{2}$ | $\mathrm{R}_{\mathrm{thJC}}$ | 0.75 |  |

## Notes

a．Duty cycle $\leq 1 \%$ ．
b．See SOA curve for voltage derating．
c．When mounted on $1^{1 "}$ square PCB（FR4 material）．

## SPECIFICATIONS（ $\mathrm{T}_{\mathrm{J}}=25^{\circ} \mathrm{C}$ ，unless otherwise noted）

| PARAMETER | SYMBOL | TEST CONDITIONS | MIN． | TYP． | MAX． | UNIT |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| Static |  |  |  |  |  |  |
| Drain－Source Breakdown Voltage | $V_{\text {DS }}$ | $\mathrm{V}_{\mathrm{GS}}=0 \mathrm{~V}, \mathrm{I}_{\mathrm{D}}=250 \mu \mathrm{~A}$ | 80 | － | － | V |
| Gate Threshold Voltage | $\mathrm{V}_{\mathrm{GS} \text {（th）}}$ | $\mathrm{V}_{\mathrm{DS}}=\mathrm{V}_{\mathrm{GS}}, \mathrm{I}_{\mathrm{D}}=250 \mu \mathrm{~A}$ | 2.5 | － | 4.5 |  |
| Gate－Body Leakage | $\mathrm{I}_{\text {GSS }}$ | $\mathrm{V}_{\mathrm{DS}}=0 \mathrm{~V}, \mathrm{~V}_{\mathrm{GS}}= \pm 20 \mathrm{~V}$ | － | － | $\pm 100$ | nA |
| Zero Gate Voltage Drain Current | Idss | $\mathrm{V}_{\mathrm{DS}}=80 \mathrm{~V}, \mathrm{~V}$ GS $=0 \mathrm{~V}$ | － | － | 1 | $\mu \mathrm{A}$ |
|  |  | $\mathrm{V}_{\text {DS }}=80 \mathrm{~V}, \mathrm{~V}$ GS $=0 \mathrm{~V}, \mathrm{~T}_{\mathrm{J}}=125^{\circ} \mathrm{C}$ | － | － | 100 |  |
|  |  | $\mathrm{V}_{\text {DS }}=80 \mathrm{~V}, \mathrm{~V}$ Gs $=0 \mathrm{~V}, \mathrm{~T}_{\mathrm{J}}=175{ }^{\circ} \mathrm{C}$ | － | － | 2 | mA |
| On－State Drain Current ${ }^{\text {a }}$ | $I_{\text {D（on）}}$ | $\mathrm{V}_{\mathrm{DS}} \geq 10 \mathrm{~V}, \mathrm{~V}_{\mathrm{GS}}=10 \mathrm{~V}$ | 90 | － | － | A |
| Drain－Source On－State Resistance ${ }^{\text {a }}$ | $\mathrm{R}_{\mathrm{DS} \text {（on）}}$ | $\mathrm{V}_{\mathrm{GS}}=10 \mathrm{~V}, \mathrm{I}_{\mathrm{D}}=30 \mathrm{~A}$ | － | 6 | － | $\mathrm{m} \Omega$ |
|  |  | $\mathrm{V}_{\mathrm{GS}}=4.5 \mathrm{~V}, \mathrm{I}_{\mathrm{D}}=30 \mathrm{~A}$ | － | 10 | － |  |
| Forward Transconductance ${ }^{\text {a }}$ | $\mathrm{gfs}_{\text {fs }}$ | $\mathrm{V}_{\mathrm{DS}}=15 \mathrm{~V}, \mathrm{I}_{\mathrm{D}}=30 \mathrm{~A}$ | － | 85 | － | S |
| Dynamic ${ }^{\text {b }}$ |  |  |  |  |  |  |
| Input Capacitance | $\mathrm{C}_{\text {iss }}$ | $\mathrm{V}_{\mathrm{GS}}=0 \mathrm{~V}, \mathrm{~V}_{\mathrm{DS}}=40 \mathrm{~V}, \mathrm{f}=1 \mathrm{MHz}$ | － | 3330 | － | pF |
| Output Capacitance | $\mathrm{C}_{\text {oss }}$ |  | － | 1395 | － |  |
| Reverse Transfer Capacitance | $\mathrm{Cr}_{\text {rss }}$ |  | － | 95 | － |  |
| Total Gate Charge ${ }^{\text {c }}$ | $\mathrm{Q}_{\mathrm{g}}$ | $\mathrm{V}_{\mathrm{DS}}=40 \mathrm{~V}, \mathrm{~V}_{\mathrm{GS}}=10 \mathrm{~V}, \mathrm{I}_{\mathrm{D}}=30 \mathrm{~A}$ | － | 53.5 | 81 | nC |
| Gate－Source Charge ${ }^{\text {c }}$ | $\mathrm{Q}_{\mathrm{gs}}$ |  | － | 14.5 | － |  |
| Gate－Drain Charge ${ }^{\text {c }}$ | $\mathrm{Q}_{\mathrm{gd}}$ |  | － | 13.2 | － |  |
| Gate Resistance | $\mathrm{R}_{\mathrm{g}}$ | $\mathrm{f}=1 \mathrm{MHz}$ | 0.9 | 1.9 | 3.8 | $\Omega$ |
| Turn－On Delay Time ${ }^{\text {c }}$ | $\mathrm{t}_{\mathrm{d}(\mathrm{on})}$ | $\begin{gathered} V_{D D}=40 \mathrm{~V}, R_{L}=1.67 \Omega \\ \mathrm{I}_{\mathrm{D}} \cong 30 \mathrm{~A}, \mathrm{~V}_{\mathrm{GEN}}=10 \mathrm{~V}, \mathrm{R}_{\mathrm{g}}=1 \Omega \end{gathered}$ | － | 13 | 26 | ns |
| Rise Time ${ }^{\text {c }}$ | $t_{r}$ |  | － | 22 | 44 |  |
| Turn－Off Delay Time ${ }^{\text {c }}$ | $\mathrm{t}_{\mathrm{d} \text {（off）}}$ |  | － | 27 | 54 |  |
| Fall Time ${ }^{\text {c }}$ | $\mathrm{t}_{\mathrm{f}}$ |  | － | 9 | 18 |  |
| Drain－Source Body Diode Ratings and Characteristics ${ }^{\mathbf{b}}\left(\mathrm{T}_{\mathrm{C}}=25^{\circ} \mathrm{C}\right)$ |  |  |  |  |  |  |
| Pulsed Current（ $\mathrm{t}=100 \mu \mathrm{~s}$ ） | $I_{\text {SM }}$ |  | － | － | 240 | A |
| Forward Voltage ${ }^{\text {a }}$ | $\mathrm{V}_{\mathrm{SD}}$ | $\mathrm{I}_{\mathrm{F}}=30 \mathrm{~A}, \mathrm{~V}_{\mathrm{GS}}=0 \mathrm{~V}$ | － | 0.86 | 1.4 | V |
| Reverse Recovery Time | $\mathrm{t}_{\mathrm{rr}}$ | $\mathrm{I}_{\mathrm{F}}=30 \mathrm{~A}, \mathrm{di} / \mathrm{dt}=100 \mathrm{~A} / \mu \mathrm{s}$ | － | 88 | 176 | ns |
| Peak Reverse Recovery Charge | $\mathrm{I}_{\mathrm{RM}(\mathrm{REC})}$ |  | － | 5 | 10 | A |
| Reverse Recovery Charge | $\mathrm{Q}_{\mathrm{rr}}$ |  | － | 0.22 | 0.44 | $\mu \mathrm{C}$ |

## Notes

a．Pulse test；pulse width $\leq 300 \mu \mathrm{~s}$ ，duty cycle $\leq 2 \%$ ．
b．Guaranteed by design，not subject to production testing．
c．Independent of operating temperature．

Stresses beyond those listed under＂Absolute Maximum Ratings＂may cause permanent damage to the device．These are stress ratings only，and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied．Exposure to absolute maximum rating conditions for extended periods may affect device reliability．

TYPICAL CHARACTERISTICS $\left(\mathrm{T}_{\mathrm{A}}=25^{\circ} \mathrm{C}\right.$ ，unless otherwise noted）


Output Characteristics


Transconductance


Capacitance


Transfer Characteristics


On－Resistance vs．Drain Current


Gate Charge

TYPICAL CHARACTERISTICS $\left(\mathrm{T}_{\mathrm{A}}=25^{\circ} \mathrm{C}\right.$ ，unless otherwise noted）


On－Resistance vs．Junction Temperature


On－Resistance vs．Gate－to－Source Voltage


Source Drain Diode Forward Voltage


Threshold Voltage


Drain Source Breakdown vs．Junction Temperature


Current De－Rating

THERMAL RATINGS $\left(\mathrm{T}_{\mathrm{A}}=25^{\circ} \mathrm{C}\right.$ ，unless otherwise noted）


THERMAL RATINGS $\left(\mathrm{T}_{\mathrm{A}}=25^{\circ} \mathrm{C}\right.$ ，unless otherwise noted）


Normalized Thermal Transient Impedance，Junction－to－Case
Note
－The characteristics shown in the two graphs
－Normalized Transient Thermal Impedance Junction to Ambient（ $25{ }^{\circ} \mathrm{C}$ ）
－Normalized Transient Thermal Impedance Junction to Case $\left(25^{\circ} \mathrm{C}\right)$
are given for general guidelines only to enable the user to get a＂ball park＂indication of part capabilities．The data are extracted from single pulse transient thermal impedance characteristics which are developed from empirical measurements．The latter is valid for the part mounted on printed circuit board－FR4，size $1^{\prime \prime} \times 1$＂x 0．062＂，double sided with 2 oz．copper， $100 \%$ on both sides．The part capabilities can widely vary depending on actual application parameters and operating conditions．

## TO－263（D²PAK）：3－LEAD




DETAIL A（ROTATED $90^{\circ}$ ）


## Notes

1．Plane $B$ includes maximum features of heat sink tab and plastic．
2．No more than $25 \%$ of L 1 can fall above seating plane by max． 8 mils．
3．Pin－to－pin coplanarity max． 4 mils．
4．＊：Thin lead is for SUB，SYB．
Thick lead is for SUM，SYM，SQM．
5．Use inches as the primary measurement．
This feature is for thick lead．

| DIM． |  | INCHES |  | MILLIMETERS |  |
| :---: | :---: | :---: | :---: | :---: | :---: |
|  |  | MIN． | MAX． | MIN． | MAX． |
|  | A | 0.160 | 0.190 | 4.064 | 4.826 |
|  | b | 0.020 | 0.039 | 0.508 | 0.990 |
|  | b1 | 0.020 | 0.035 | 0.508 | 0.889 |
|  | b2 | 0.045 | 0.055 | 1.143 | 1.397 |
| $\mathrm{C}^{*}$ | Thin lead | 0.013 | 0.018 | 0.330 | 0.457 |
|  | Thick lead | 0.023 | 0.028 | 0.584 | 0.711 |
| c1 | Thin lead | 0.013 | 0.017 | 0.330 | 0.431 |
|  | Thick lead | 0.023 | 0.027 | 0.584 | 0.685 |
| c2 |  | 0.045 | 0.055 | 1.143 | 1.397 |
| D |  | 0.340 | 0.380 | 8.636 | 9.652 |
| D1 |  | 0.220 | 0.240 | 5.588 | 6.096 |
| D2 |  | 0.038 | 0.042 | 0.965 | 1.067 |
| D3 |  | 0.045 | 0.055 | 1.143 | 1.397 |
| D4 |  | 0.044 | 0.052 | 1.118 | 1.321 |
| E |  | 0.380 | 0.410 | 9.652 | 10.414 |
| E1 |  | 0.245 | － | 6.223 | － |
| E2 |  | 0.355 | 0.375 | 9.017 | 9.525 |
| E3 |  | 0.072 | 0.078 | 1.829 | 1.981 |
| e |  | 0．100 BSC |  | 2．54 BSC |  |
| K |  | 0.045 | 0.055 | 1.143 | 1.397 |
| L |  | 0.575 | 0.625 | 14.605 | 15.875 |
| L1 |  | 0.090 | 0.110 | 2.286 | 2.794 |
| L2 |  | 0.040 | 0.055 | 1.016 | 1.397 |
| L3 |  | 0.050 | 0.070 | 1.270 | 1.778 |
| L4 |  | 0.010 BSC |  | 0.254 BSC |  |
|  | M | － | 0.002 | － | 0.050 |
| ECN：T13－0707－Rev．K，30－Sep－13 DWG： 5843 |  |  |  |  |  |

## RECOMMENDED MINIMUM PADS FOR D²PAK：3－Lead



Recommended Minimum Pads
Dimensions in Inches／（mm）

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